

8388608-BIT (524288-WORD BY 16-BIT) CMOS STATIC RAM

Those are summarized in the part name table below.

DESCRIPTION

The M5M5W816 is a family of low voltage 8-Mbit static RAMs organized as 524288-words by 16-bit, fabricated by Mitsubishi's high-performance 0.18µm CMOS technology.

The M5M5W816 is suitable for memory applications where a simple interfacing, battery operating and battery backup are the important design objectives.

M5M5W816WG is packaged in a CSP (chip scale package), with the outline of 7.5mm x 8.5mm, ball matrix of 6 x 8 (48ball) and ball pitch of 0.75mm. It gives the best solution for a compaction

of mounting area as well as flexibility of wiring pattern of printed circuit boards.

FEATURES

- Single 2.7~3.0V power supply
- Small stand-by current: 0.1µA (2V, typ.)
- No clocks. No refresh
- Data retention supply voltage =2.0V
- All inputs and outputs are TTL compatible.
- Easy memory expansion by S1#, S2, BC1# and BC2#
- Common Data I/O
- Three-state outputs: OR-tie capability
- OE prevents data contention in the I/O bus
- Process technology: 0.18µm CMOS
- Package: 48ball 7.5mm x 8.5mm CSP

Version,		1			St	and-by	curre	nt		Activ e
Operating Part name		Power		* Ty pical		Ratings (max.))	current
temperature		Supply	max.	25°C	40°C	25°C	40°C	70°C	85°C	lcc1 * (typ.)
I-version -40 ~ +85°C	M5M5W816WG - 85HI	2.7 ~ 3.0V	85ns	0.5	1.0	2	4	20	40	40mA (10MHz) 10mA (1MHz)

^{*} Typical parameter indicates the value for the center

PIN CONFIGURATION

(TOP VIEW)

$\bigcirc 1 \stackrel{2}{\sim}$	$\frac{3}{2}$	5 6
A (BC1#) (OE	(#) (A0) (A1) (A2) (S2)
B (016) (BC:	2#) (A3) (A4	S1# (DQ1)
C (DQ14) (DQ	15) (A5) (A6	DQ2 DQ3
D GND DQ	13) (A17) (A7	DQ4 VCC
E VCC DQ	12 (NC or GND) (A16	DQ5 GND
F (011) (0	10) (A14) (A15	5) (DQ7) (DQ6)
G (DQ9) (N.	C.) (A12) (A13	3) (W#) (DQ8)
H (A18) (A1	B A9 (A10) (A11) (N.C.)

Outline : 48F7Q NC : No Connection

*Don't connect E3 ball to voltage level more than 0V

Pin	Function			
A0 ~ A18	Address input			
DQ1 ~ DQ16	Data input / output			
S1#	Chip select input 1			
S2	Chip select input 2			
W#	Write control input			
OE#	Output enable input			
BC1#	Lower Byte (DQ1 ~ 8)			
BC2#	Upper Byte (DQ9 ~ 16)			
Vcc	Power supply			
GND	Ground supply			

of distribution, and is not 100% tested.



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FUNCTION

The M5M5W816WG is organized as 524288-words by 16-bit. These devices operate on a single +2.7~3.0V power supply, and are directly TTL compatible to both input and output. Its fully static circuit needs no clocks and no refresh, and makes it useful.

The operation mode are determined by a combination of the device control inputs BC1#, BC2#, S1#, S2, W# and OE#. Each mode is summarized in the function table.

A write operation is executed whenever the low level W# overlaps with the low level BC1# and/or BC2# and the low level S1# and the high level S2. The address(A0~A18) must be set up before the write cycle and must be stable during the entire cycle.

A read operation is executed by setting W# at a high level and OE# at a low level while BC1# and/or BC2# and S1# and S2 are in an active state(S1#=L,S2=H).

When setting BC1# at the high level and other pins are in an active stage, upper-byte are in a selectable mode in which both reading and writing are enabled, and lower-byte are in a non-selectable mode. And when setting BC2# at a high level and other pins are in an active stage, lower-byte are in a selectable mode and upper-byte are in a non-selectable mode.

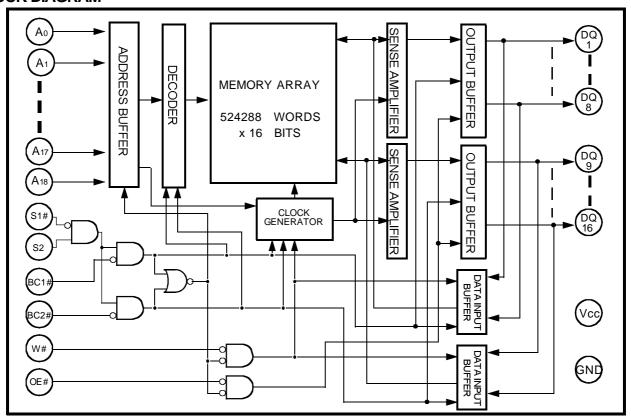
When setting BC1# and BC2# at a high level or S1# at a high level or S2 at a low level, the chips are in a non-selectable mode in which both reading and writing are disabled. In this mode, the output stage is in a high-impedance state, allowing OR-tie with other chips and memory expansion by BC1#, BC2# and S1#, S2.

The power supply current is reduced as low as $0.1\mu A(25^{\circ}C,$ typical), and the memory data can be held at +2.0V power supply, enabling battery back-up operation during power failure or power-down operation in the non-selected mode.

FUNCTION TABLE

S1#	S2	BC1#	BC2#	W#	OE#	Mode	DQ1~8	DQ9~16	Icc
Н	L	Χ	Χ	Χ	Χ	Non selection	High-Z	High-Z	Standby
L	ᆚ	Χ	Χ	Χ	Χ	Non selection	High-Z	High-Z	Standby
Н	Ι	Χ	Χ	Χ	Χ	Non selection	High-Z	High-Z	Standby
Χ	Χ	Η	Н	Χ	Χ	Non selection	High-Z	High-Z	Standby
L	Ι	L	Н	L	Χ	Write	Din	High-Z	Activ e
L	Η	L	Н	Н	L	Read	Dout	High-Z	Activ e
L	Н	L	Н	Н	Н		High-Z	High-Z	Activ e
L	Η	Η	L	L	Χ	Write	High-Z	Din	Activ e
L	Η	Н	L	Н	L	Read	High-Z	Dout	Activ e
L	Η	Η	L	Н	Н		High-Z	High-Z	Activ e
L	Н	L	L	L	Χ	Write	Din	Din	Activ e
L	Н	L	L	Н	L	Read	Dout	Dout	Activ e
L	Ι	L	L	Ι	Η		High-Z	High-Z	Activ e

BLOCK DIAGRAM



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ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter	Conditions	Ratings	Units
Vcc	Supply voltage	With respect to GND	-0.3* ~ +4.6	
Vı	Input voltage	With respect to GND	-0.3* ~ Vcc + 0.3 (max. 4.6V)	V
Vo	Output voltage	With respect to GND	0 ~ Vcc	
Pd	Power dissipation	Ta= 25°C	700	mW
Та	Operating temperature		- 40 ~ +85	°C
Tstg	Storage temperature		- 65 ~ + 150	°C

* -3.0V in case of AC (Pulse width \leq 30ns)

DC ELECTRICAL CHARACTERISTICS

(Vcc=2.7 ~ 3.0V, unless otherwise noted)

O made al	5 ,	0 177		Limits	1		
Symbol	Parameter	Conditions		Min	Тур	Max	Units
VIH	High-level input voltage			2.2		Vcc+0.2V	
VIL	Low-lev el input v oltage			-0.2 *		0.6	
Vон	High-level output voltage	Iон= -0.5mA		2.4			V
Vol	Low-level output voltage	IoL=2mA				0.4	
lı	Input leakage current	Vı =0 ~ Vcc				±1	^
lo	Output leakage current	BC1# and BC2# =VIH or S1# =VIH or S2=VIL or OE#	=VIH, VI/O=0 ~ Vcc			±1	μA
loot		BC1# and BC2#≤ 0.2V, S1#≤ 0.2V, S2 ≥ Vcc-0.2V	f= 10MHz	-	30	40	
lcc1	(AC,MOS level)	other inputs $\leq 0.2V$ or $\geq Vcc-0.2V$ Output - open (duty 100%)	f= 1MHz	1	5	10	
	Active supply current	BC1# and BC2#=VIL, S1#=VIL, S2=VIH other pins =VIH or VIL	f= 10MHz	1	30	40	mA
lcc2	(AC,TTL level)	Output - open (duty 100%)	f= 1MHz	-	5	10	
		(1) S1# ≥ Vcc - 0.2V, S2 ≥ Vcc - 0.2V,	~ +25°C	-	0.5	2	
lcc3	Stand by supply current	other inputs = $0 \sim Vcc$ (2) S2 $\leq 0.2V$,	~ +40°C	-	1.0	4	
1003	(AC,MOS level)	other inputs = 0 ~ Vcc (3) BC1# and BC2#≧ Vcc - 0.2V	~ +70°C	ı	ı	20	μΑ
		S1#≤0.2V, S2≥Vcc - 0.2V other inputs = 0 ~ Vcc	~ +85°C	-	-	40	
lcc4	Stand by supply current (AC,TTL level)	BC1# and BC2# =VIH or S1# =VIH or S2=VIL Other inputs= 0 ~ Vcc		-	-	2	mA

Note 1: Direction for current flowing into IC is indicated as positive (no mark)

CAPACITANCE

(Vcc=2.7 ~ 3.0V, unless otherwise noted)

Symbo	Parameter	Conditions		Limits	i	
Syllibo	Falailletei	Conditions	Min	Тур	Max	Units
Сі	Input capacitance	Vi=GND, Vi=25mVrms, f=1MHz			10	pF
Со	Output capacitance	Vo=GND,Vo=25mVrms, f=1MHz			10	pΓ

^{* -3.0}V in case of AC (Pulse width ≤ 30ns)

Note 2: Typical parameter indicates the value for the center of distribution, and is not 100% tested.

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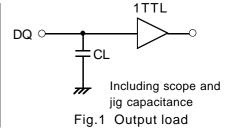
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AC ELECTRICAL CHARACTERISTICS

(Vcc=2.7 ~ 3.0V, unless otherwise noted)

(1) TEST CONDITIONS

Supply voltage	2.7~3.0V			
Input pulse	VIH=2.4V, VIL=0.4V			
Input rise time and fall time	5ns			
Reference level	Voh=Vol=1.5V Transition is measured ±200mV from steady state voltage.(for ten,tdis)			
Output loads	Fig.1,CL=30pF			
	CL=5pF (for ten,tdis)			



(2) READ CYCLE

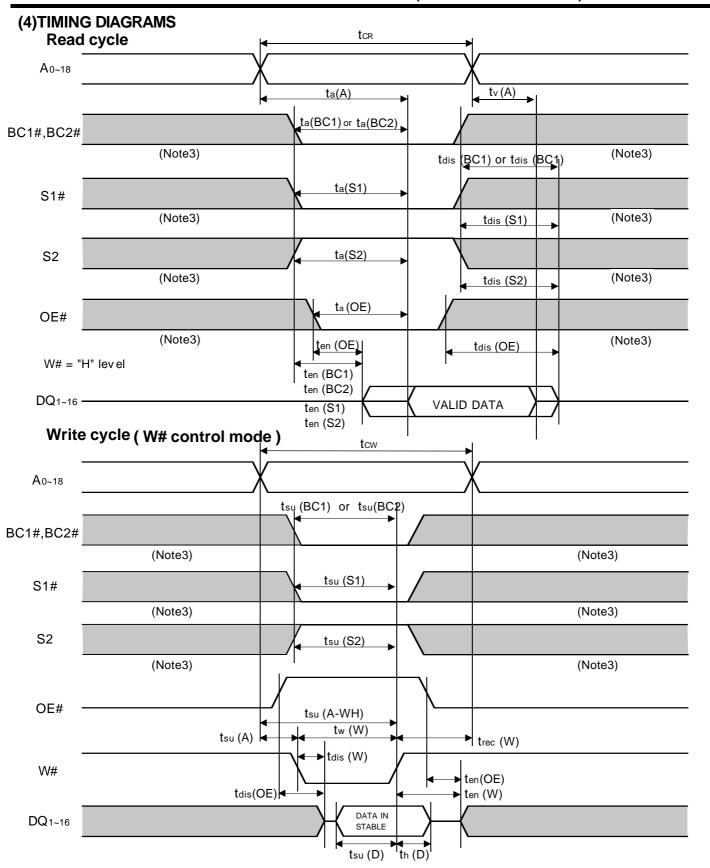
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Symbol	Parameter	Min	Max	Units
tcr	Read cycle time	85		ns
ta(A)	Address access time		85	ns
ta(S1)	Chip select 1 access time		85	ns
ta(S2)	Chip select 2 access time		85	ns
ta(BC1)	Byte control 1 access time		85	ns
ta(BC2)	Byte control 2 access time		85	ns
ta(OE)	Output enable access time		45	ns
tdis(S1)	Output disable time after S1# high		30	ns
tdis(S2)	Output disable time after S2 low		30	ns
tdis(BC1)	Output disable time after BC1# high		30	ns
tdis(BC2)	Output disable time after BC2# high		30	ns
tdis(OE)	Output disable time after OE# high		30	ns
ten(S1)	Output enable time after S1# low	10		ns
ten(S2)	Output enable time after S2 high	10		ns
tdis(BC1)	Output enable time after BC1# low	5		ns
tdis(BC2)	Output enable time after BC2# low	5		ns
ten(OE)	Output enable time after OE# low	5		ns
t∨(A)	Data valid time after address	10		ns

(3) WRITE CYCLE

		Li	Limits			
Symbol	Parameter	Min	Max	- Units		
tcw	Write cycle time	85		ns		
t _w (W)	Write pulse width	60		ns		
tsu(A)	Address setup time	0		ns		
tsu(A-WH)	Address setup time with respect to W#	70		ns		
tsu(BC1)	Byte control 1 setup time	70		ns		
tsu(BC2)	Byte control 2 setup time	70		ns		
tsu(S1)	Chip select 1 setup time	70		ns		
tsu(S2)	Chip select 2 setup time	70		ns		
tsu(D)	Data setup time	45		ns		
th(D)	Data hold time	0		ns		
t _{rec} (W)	Write recovery time	0		ns		
t _{dis} (W)	Output disable time from W# low		30	ns		
tdis(OE)	Output disable time from OE# high		30	ns		
ten(W)	Output enable time from W# high	5		ns		
ten(OE)	Output enable time from OE# low	5		ns		



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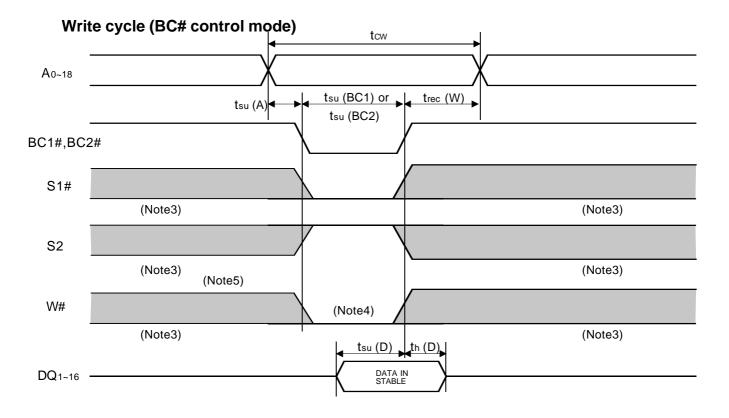


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Note 3: Hatching indicates the state is "don't care".

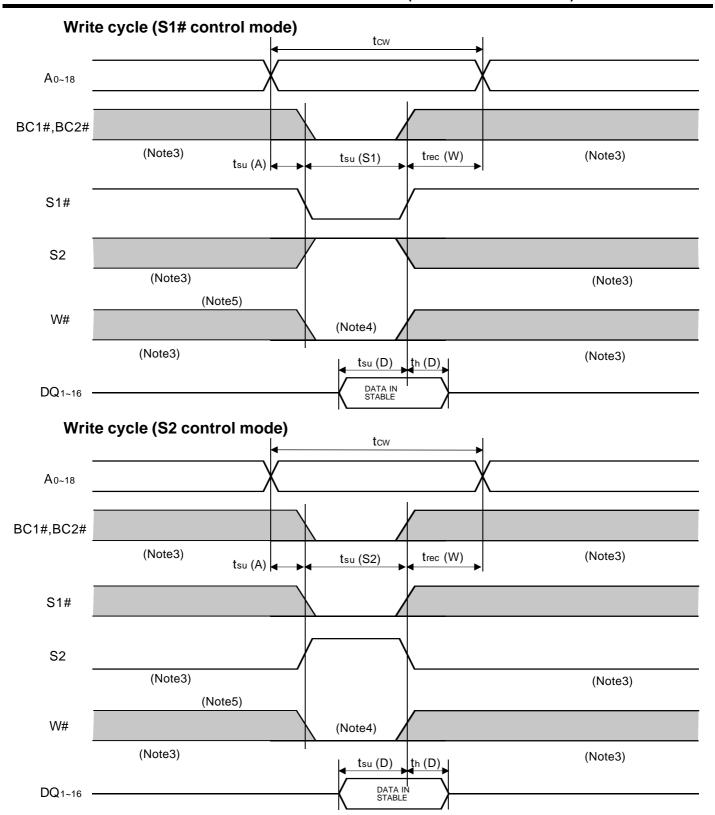
Note 4: A Write occurs during S1# low, S2 high overlaps BC1# and/or BC2# low and W# low.

Note 5: When the falling edge of W# is simultaneously or prior to the falling edge of BC1# and/or BC2# or the falling edge of S1# or rising edge of S2, the outputs are maintained in the high impedance state.

Note 6: Don't apply inverted phase signal externally when DQ pin is in output mode.



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POWER DOWN CHARACTERISTICS

(1) ELECTRICAL CHARACTERISTICS

0	Danamatan			Limits			
Symbol	Parameter	Test conditions	Min	Тур	Max	Units	
Vcc (PD)	Power down supply voltage			2.0			V
VI (BC#)	Byte control input BC1# &	2.2V ≤ Vcc(PD)		2.0			
	BC2#	2.0V≦ Vcc(PD)≦2.2V			Vcc(PD)		V
Maria		2.2V≦ Vcc(PD)		2.0			
VI (S1#)	Chip select input S1#	2.0V ≦ Vcc(PD) ≦2.2V			Vcc(PD)		V
VI (S2)	Chip select input S2					0.2	
		Vcc=2.0V (1) S1# ≥ Vcc - 0.2V,	~ +25°C	-	0.1	1.5	
Icc (PD)	Power down	other inputs = 0 ~ Vcc (2) S2 ≤ 0.2V,	~ +40°C	-	0.2	3	
supply current	supply current	other inputs = 0 ~ Vcc (3) BC1# and BC2#≧ Vcc - 0.2V	~ +70°C	-	-	15	μΑ
		S1# ≤ 0.2V, S2 ≥ Vcc - 0.2V other inputs = 0 ~ Vcc	~ +85°C	-	-	30	

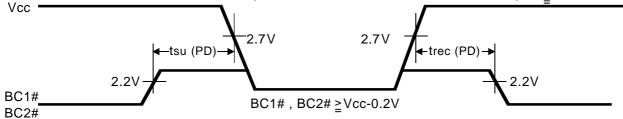
Note 2: Typical parameter of Icc(PD) indicates the value for the center of distribution, and is not 100% tested.

(2) TIMING REQUIREMENTS

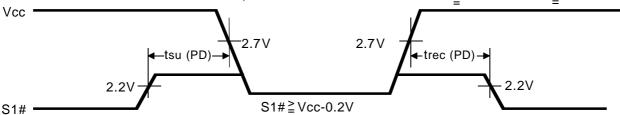
	Demonstra					
Symbol	Parameter	Test conditions	Min	Тур	Max	Units
tsu (PD)	Power down set up time		0			ns
trec (PD)	Power down recovery time		5			ms

(3) TIMING DIAGRAM

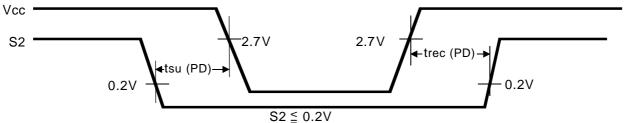
BC# control mode On the BC# control mode, the level of S1# and S2 must be fixed at S1#, S2 \geq Vcc-0.2V or S2 \leq 0.2V

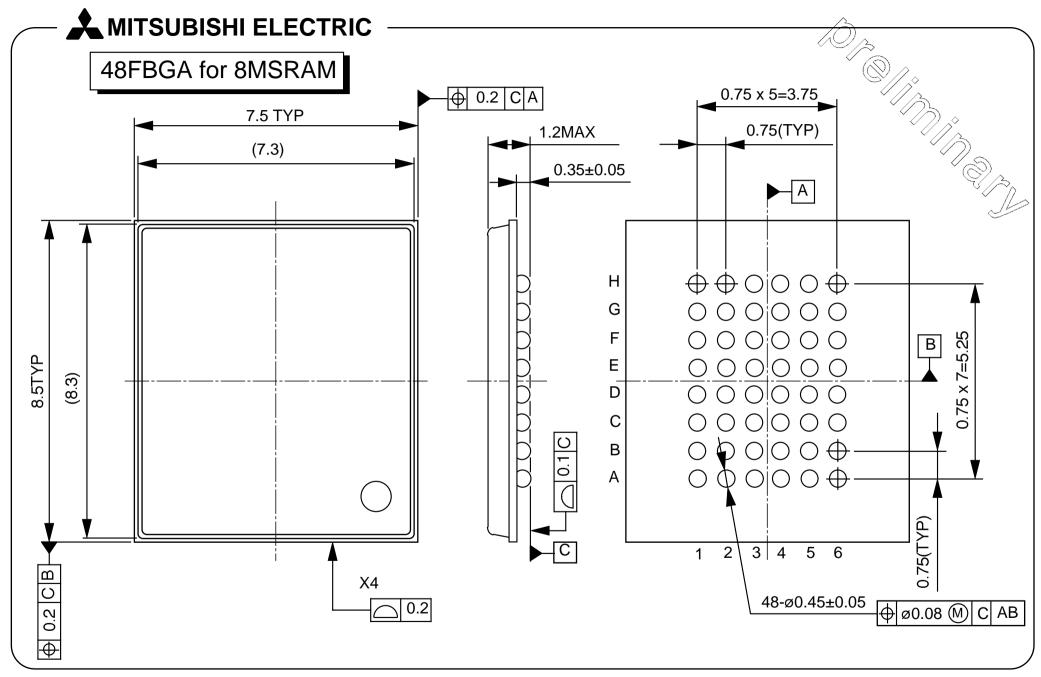


S1# control mode On the S1# control mode, the level of S2 must be fixed at S2 \geq Vcc-0.2V or S2 \leq 0.2V



S2 control mode





Code: _____ Date: 15th.Dec.2000 Page ____ of_

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